

**Search Notes**

Application/Control No.

10/618,850

Examiner

David Nhu

Applicant(s)/Patent under  
Reexamination

TANAKA ET AL.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
438	30	7/6/2005	DN
	45, 46		
	77		
	154, 157		
	159		
	163, 164		
	191, 194		
	197		
	181		
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	174		
	706		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
SEARCHED IN EAST	7/6/2005	DN
SEARCHED IN EAST	6/12/2006	DN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner